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Spin-Orbit induced phase-shift in Bi₂Se₃ Josephson junctions

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The transmission of Cooper pairs between two weakly coupled superconductors produces a superfluid current and a phase difference; the celebrated Josephson effect¹. Because of time-reversal and parity symmetries, there is no Josephson current without a phase difference between two superconductors. Reciprocally, when those two symmetries are broken, an anomalous supercurrent can exist in the absence of phase bias or, equivalently, an anomalous phase shift φ_0 can exist in the absence of a superfluid current. We report on the observation of an anomalous phase shift φ_0 in hybrid SNS Josephson junctions fabricated with the topological insulator $\text{Bi}_2\text{Se}_3^{2,3}$ submitted to an in-plane magnetic field. This anomalous phase shift

 φ_0 is observed directly through measurements of the current-phase relationship (CPR) in a Josephson Interferometer (JI). This result provides a direct measurement of the spin-orbit coupling strength and open new possibilities for phase-controlled Josephson devices made from materials with strong spin-orbit coupling.

In Josephson junctions, the CPR is given by the first Josephson equation⁴, $I_{\rm J}(\varphi)=I_0\sin(\varphi+\varphi_0)$. Time-reversal and spatial parity symmetries⁵, P_x , P_y , P_z impose the equality $I_{\rm J}(\varphi\to 0)=0$ and so only two states for the phase shift φ_0 are possible. $\varphi_0=0$ in standard junctions and $\varphi_0=\pi$ in presence of a large Zeeman field, as obtained in hybrid superconducting-ferromagnetic junctions⁶⁻⁸ or in large g-factor materials under magnetic field^{9,10}.

To observe an anomalous phase shift φ_0 intermediate between 0 and π , both time-reversal and parity symmetries must be broken^{11–23}. This can be obtained in systems with both a Zeeman field and a Rashba-like term $H_R = \frac{\alpha}{\hbar}(\vec{p} \times \vec{e_z}).\vec{\sigma}$ in the Hamiltonian^{13,20}, where α is the Rashba coefficient and $\vec{e_z}$ the direction of the Rashba electric field. Physically, this term leads to a spin-induced dephasing of the superconducting-wave function.

Because of its large g-factor $g=19.5^{24}$ and large Rashba coefficient, $\mathrm{Bi_2Se_3}$ is a promising candidate for observing the anomalous Josephson effect. In this topological insulator², the effective Rashba coefficient of the topological Dirac states is about $\alpha\simeq 3~\mathrm{eVÅ^{25}}$, while the Rashba coefficient of the bulk states, induced by the broken inversion symmetry at the surface, has a value in the range 0.3 - $1.3~\mathrm{eVÅ}$ as measured by photoemission^{26,27}.

In the ballistic regime¹³, an anomalous phase shift $\varphi_0 = \frac{4E_Z\alpha L}{(\hbar v_F)^2}$ is predicted when the magnetic field B is perpendicular to the Rashba electric field, where $E_Z = \frac{1}{2}g\mu_B B$ is the Zeeman energy, L is the distance between the superconductors and v_F is the Fermi velocity of the barrier material. For bulk states, with $\alpha \approx 0.4$ eVÅ and v_F =3.2 10^5 ms⁻¹, for a typical junction length L=150 nm, a magnetic field B=0.25 T generates an anomalous phase $\varphi_0 \simeq 0.02$ π , while for Dirac states²⁵ with v_F =4.5 10^5 ms⁻¹, $\varphi_0 \simeq 0.05$ π .

To test this theoretical prediction, we fabricated single Josephson junctions and JIs from Bi_2Se_3 thin films of 20 quintuple layers thick, ~ 20 nm, grown by Molecular Beam Epitaxy and protected by a Se layer, see Supp. Note 1. and Fig. S1. As described in Fig. S2, these junctions are in the diffusive regime where the anomalous phase shift is given by²⁰:

$$\varphi_0 = \frac{\tau m^{*2} E_{\mathbf{Z}}(\alpha L)^3}{3\hbar^6 D} \tag{1}$$

where $\tau=0.13$ ps is the elastic scattering time, $D=\frac{1}{3}v_{\rm F}^2\tau=40~{\rm cm^2s^{-1}}$ is the diffusion constant and $m^*=0.25~m_e$ is the effective electron mass.

For the fabrication of the Josephson junctions, the Se capping layer is removed just before evaporation of the superconducting Ti/Al electrodes, see methods and Fig. S3. The JI shown in Fig. 1a consists of two junctions in parallel of widths $W_1=600$ nm and $W_2=60$ nm, respectively. The phase differences φ_1 and φ_2 for the two junctions are linked by the relation $\varphi_1+\varphi_2=2\pi n\frac{\phi}{\phi_0}$, where $\phi=B_zS$ is the magnetic flux enclosed in the JI of surface S, B_z is a small magnetic field perpendicular to the sample, i.e. along $\vec{e_z}$, and ϕ_0 is the flux quantum. In this situation, the Zeeman

energy is negligible and oriented along the Rashba electric field, which implies that $\varphi_0 = 0$.

As the critical current I_{c_1} is much higher than I_{c_2} , then $\varphi_1=\pi/2$ and $I_c=I_{c_1}+I_{c_2}\cos(\omega B_z)$ with $\omega=2\pi S/\phi_0^{28}$. Thus, a measurement of the critical current I_c as function of B_z provides a measure of the current I_{c_2} as function of φ_2 , i.e. the CPR. From the voltage map as a function of current I and B_z , shown Fig. 1b, the critical current I_c is extracted when the voltage across the device exceeds the value $V_{\rm switch}=4~\mu{\rm V}$, as shown in Fig. 1c. We find that the CPR displays a conventional sinusoidal form $I_{\rm J}=I_{\rm c}\sin(\varphi)$, as shown by the fit in Fig. 1d. Furthermore, under microwave irradiation, the JI displays a conventional, 2π periodic, Shapiro pattern, as shown Fig. 2, and detailed discussion in Supp. Note 2.

Fig. 3bcd show resistance maps dV/dI of a single junction, Fig. 3a, as function of current I and B_z for different values of an in-plane magnetic field, B_y . Fig. 3e shows the corresponding critical current curves. A Fraunhofer pattern is observed with the first node located at $B_0 \simeq 1.2$ mT. This value is consistent with the theoretical value $B_0 = \frac{\phi_0}{W(L+2\lambda_z)}$, using the effective magnetic penetration depth $\lambda_z = 175$ nm and taking into account flux-focusing effects, see Supp. Note 3. While for $B_y = 0$, the Fraunhofer pattern is symmetric with respect to B_z , this pattern becomes asymmetric upon increasing the amplitude of B_y . This evolution is shown in the critical current map as a function of B_z and B_y in Fig. 3f. We observed a much less pronounced asymmetry when we apply the magnetic field in the x direction as shown in Fig. S4. Similar behavior has been observed recently in InAs²⁹ interpreted as the consequence of a combination of spin-orbit, Zeeman and disorder effects. As described in Ref.[5], the generation of an anomalous phase shift requires

[h]

	Broken by
$P_y P_x$	α, V_x, V_y
$\sigma_z P_y P_x$	B_x,B_y,V_x,V_y
$\sigma_x P_y T$	B_x , α , V_y
$\sigma_y P_y T$	B_y,V_y

Table 1: Symmetry operations U protecting $H(\varphi)=H(-\varphi)$, see Ref. ⁵. The symmetry operations on the left column are broken by one of the parameters on the right column. These parameters include the in-plane magnetic fields B_x, B_y , the asymmetric disorder potentials V_x, V_y and the spin-orbit term α which is the consequence of the structural inversion asymmetry (Rashba). To generate an anomalous phase φ_0 , each symmetry operator, one per line of the table, must be broken. For example, the combination of the magnetic field B_y and the spin orbit coupling α is enough to break all symmetries.

breaking all symmetry operations U leaving $UH(\varphi)U^{\dagger}=H(-\varphi)$, where H is the full Hamiltonian of the system including spin-orbit interactions. These symmetry operations are shown Table I together with the parameters breaking those symmetries. This table shows that for a system with a finite spin-orbit coefficient α , finite B_y is sufficient to generate an anomalous phase shift. However, additional symmetry operations U leaving $UH(B_z,\varphi)U^{\dagger}=H(-B_z,\varphi)$ must be broken to generate an asymmetric Fraunhofer pattern, as shown Table S1. In addition to non-zero values for α and B_y , disorder along y direction, i.e. non-zero V_y , is required to generate an asymmetric Fraunhofer pattern. AFM images, Fig. S5g, show that the MBE films present atomic steps. Because of the dependence of the Rashba coefficient on film thickness²⁵, phase jumps along the y direction of the junction can be produced by jumps in the Rashba coefficient and explains the polarity asymmetry of the Fraunhofer pattern. As detailed in Supp. Note 4, using a simple model, the asymmetric Fraunhofer pattern measured experimentally can be simulated, as shown in Fig. 3g.

To unambiguously demonstrate that an anomalous phase shift φ_0 can be generated by finite spin-orbit coefficient α and finite magnetic field B_y alone, a direct measurement of the CPR with in-plane magnetic field is required. To that end, we measured simultaneously two JIs, oriented as sketched in Fig. 4a, differing only by orientation of the small junctions with respect to the in-plane magnetic field.

The CPRs for the two JIs are measured as function of a magnetic field making a small tilt θ with the sample plane, which produces an in-plane $B_y = B\cos(\theta)$ and a perpendicular $B_z = B\sin(\theta)$ magnetic field, as sketched in Fig. 4c. In this situation, the critical current for the reference

JI changes as $I_{\rm c} \propto \cos(\omega_{\rm ref}B)$ with $\omega_{\rm ref}=\frac{2\pi S_{\rm ref}}{\phi_0}\sin(\theta)$ where $S_{\rm ref}$ is the surface of the JI. For the anomalous JI, the critical current changes as $I_{\rm c} \propto \cos(\omega B)$ with :

$$\omega = \frac{2\pi S}{\phi_0} \sin \theta + C_{\varphi_0} \cos(\theta) \tag{2}$$

with
$$C_{arphi_0}=rac{ au m^{*2}g\mu_{
m B}(lpha L)^3}{6\hbar^6D}$$

In Eq.2, the first term arises from the flux within the JI of area S, the second term arises from the anomalous phase shift $\varphi_0 = C_{\varphi_0} B \cos(\theta)$.

Fig. 4b shows voltage maps for two different orientations θ . At low B, the two JIs are inphase and become out-of-phase at higher magnetic field, indicating that the frequency ω of the anomalous JI is slightly larger than the reference JI. This is also visible on the critical current plot, Fig. 5a, extracted from these voltage maps. To see this more clearly, the average critical current, shown as a continuous line in Fig. 5a, is removed from the critical current curve and the result shown in Fig. 5b for the two JIs. These last curves show that the anomalous JI has a frequency larger than the reference as expected from Eq. 2 where the anomalous shift leads to an enhanced frequency ω with respect to the reference JI.

One also sees that the frequency of both JIs decreases with increasing B. This is due to flux focusing that makes the effective JI area larger at low magnetic field. As flux focusing decreases upon increasing the in-plane magnetic field, this leads to a reduction of effective areas of the JI and so of the frequencies.

While the two JIs have been fabricated with nominally identical areas, to exclude that the observed difference in frequencies between the two JIs is due to a difference of areas, we plot in Fig. 5c, the frequency ratio $\frac{\omega}{\omega_{\rm ref}}(\theta)$ measured at different angles θ . Because each curve contains several periods T_i , the frequency ratio is obtained from the average between the N periods ratio as $\omega/\omega_{\rm ref}=\frac{1}{N}\sum_{i=1}^{N}\frac{T_{i,\rm ref}}{T_i}$, where $T_{i,\rm ref}$ and T_i are the ith oscillation period for the reference and for the anomalous device respectively. This method enables ignoring the flux focusing effect because the ratio is only taken between two periods measured at about the same magnetic field. We find that the experimental data follows the relation:

$$\frac{\omega}{\omega_{\text{ref}}}(\theta) = \frac{S}{S_{\text{ref}}} + \frac{C_{\varphi_0}\phi_0}{2\pi S_{\text{ref}}\tan(\theta)} \tag{3}$$

At large θ , this ratio is equal to the ratio of areas $S/S_{\rm ref} \simeq 1$, however, for small θ , this ratio increases as $1/\tan(\theta)$, indicating the presence of an anomalous phase shift φ_0 .

Another way of extracting the frequency is described in the Supp. Note 5 and leads to the same result, as shown Fig. S6.

A fit of the experimental data with Eq. 3, Fig. 5c, enables extracting the coefficient $\frac{C_{\varphi_0}\phi_0}{2\pi S_{\text{ref}}} = 4.1\ 10^{-4}$. Using the expression of C_{φ_0} given above, we calculate a spin-orbit coefficient α =0.38 eVÅ. This value of the Rashba coefficient is consistent with the value extracted from Rashba-split conduction band observed by photoemission measurements^{26,27}. A contribution from the Dirac states is possible, however, their contribution to the anomalous phase shift, calculated in the ballistic

regime, is smaller than the Rashba-split bulk states.

A detailed look at Table I shows that the anomalous shift observed here must be the consequence of finite Rashba coefficient and in-plane magnetic field. While Table I shows that disorder alone V_y is sufficient to generate an anomalous phase shift, this disorder-induced anomalous phase shift should exist even at zero magnetic field and should not change with magnetic field. In contrast, the arrows on the plots Fig. 4b and Fig. 5b show that the two JIs are in-phase at low magnetic field and become out of phase at higher magnetic field, because of the larger frequency of the anomalous device where an anomalous phase shift is induced by the in-plane magnetic field. Thus, this observation implies that disorder V_y is absent, which is plausible as the small Josephson junction is only 150 nm×150 nm. In the absence of disorder V_y , Table I shows that the only way for an anomalous phase shift to be present is that the coefficient α be non-zero. Indeed, if α were zero, the first and third symmetry operations of Table I would not be broken even with finite B_y .

To summarize, the simultaneous measurements of the CPR in two JIs making an angle of 90° with respect to the in-plane magnetic field enabled the identification of the anomalous phase shift φ_0 induced by the combination of the strong spin-orbit coupling and in-plane magnetic field. We estimated that an in-plane magnetic field of 0.25 T generates an anomalous phase shift of 2π . This anomalous phase shift can be employed to fabricate a phase battery, a quantum device of intense interest for the design and fabrication of superconducting quantum circuits^{30,31}.

Methods

Sample preparation The Bi₂Se₃ samples were grown by Molecular Beam Epitaxy. The crystalline quality of the films was monitored in-situ by reflection high energy electron diffraction and ex situ by x-ray diffraction, and by post growth verification of the electronic structure though the observation of the Dirac cone fingerprint in angle-resolved photoemission spectra as described in Ref. ³². Following growth, the samples were capped with a Se protective layer. The Josephson junctions are fabricated on these thin films with standard e-beam lithography, e-beam deposition of Ti(5nm)/Al(20-50 nm) electrodes and lift-off. The Se capping layer is removed just before metal evaporation by dipping the samples in a NMF solution of Na₂S. In the evaporator chamber, the surface is cleaned by moderate in-situ ion beam cleaning of the film surface before metal deposition. While for standard junctions, an aluminum layer 50 nm thick is usually deposited, we also fabricated junctions with 20 nm thick electrodes to increase their upper critical field as required by the experiments with in-plane magnetic field. After microfabrication, the carrier concentration is about $10^{19}~{\rm cm}^{-3}$ and the resistivity about 0.61 m Ω .cm, Fig. S1. A comparison between the normal state junction resistance of the order of 20-50 Ω and the resistivity of the films indicates negligible contact resistance, i.e. the junction resistance is due to the Bi₂Se₃ film between the electrodes.

Measurements details The values for the normal resistance and critical current values measured on 20 devices are found to be highly reproducible, demonstrating the reliability of our procedure for surface protection and preparation before evaporation of the electrodes. The devices are measured in a dilution fridge with a base temperature of 25 mK. The IV curves are measured with standards current source and low noise instrumentation amplifiers for detecting the voltage across

the junctions. The measurement lines are heavily filtered with π filters at room temperature at the input connections of the cryostat. They are also filtered on the sample stage at low temperature with 1 nF capacitances connecting the measurements lines to the ground.

Data avaibility The data that support the main findings of this study are available from the corresponding author upon request.

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Author contributions

Competing Interests The authors declare that they have no competing financial interests.

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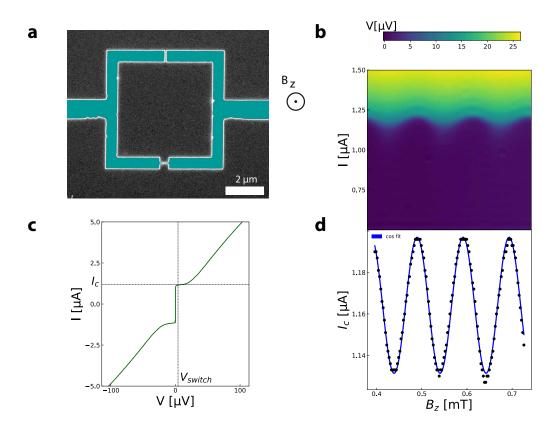


Figure 1: **Probing the CPR with a Josephson interferometer. a** SEM image of a JI device. This device consists of two Josephson junctions in parallel and enables probing the CPR of the smaller junction. **b** Voltage map as a function of current and magnetic field B_z applied perpendicular to the film plane showing zero voltage below a critical current value. The critical current of the small junction oscillates with the magnetic flux in the superconducting loop. **c** IV curve of the JI device. The critical current value I_c is extracted when the junction develops a finite voltage defined as V_{switch} and indicated by the dashed vertical line. **d** Critical current extracted from (c) as a function of B_z . The oscillations are properly described by the function $I_c(B_z) = I_{c_1} + I_{c_2} \cos(\omega B_z)$, indicating a sinusoidal CPR as expected for conventional Josephson junction.

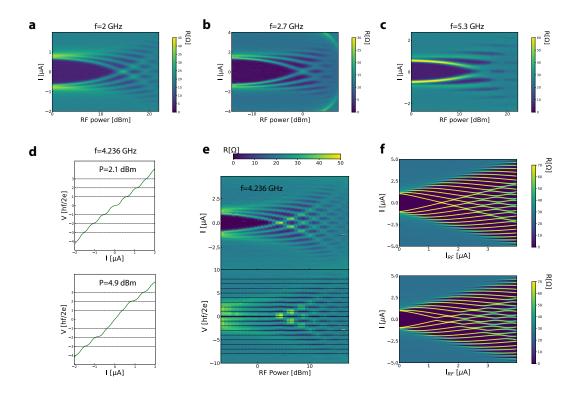


Figure 2: **A.C. Josephson effect in Bi**₂Se₃. **abc** Resistance maps as a function of current and power sets on the RF source for different microwave frequencies (a) f=2 GHz, (b) 2.7 GHz and (c) 5.3 GHz. The zero resistance regions correspond to voltage plateaus. **d** IV curves showing the Shapiro steps for two values of the microwave power. The n^{th} current step appears at a voltage $V_n = \frac{nhf}{2e}$. **e** Resistance map as a function of current (upper panel) or voltage (lower panel) and RF power at the frequency f=4.236 GHz. In the lower panel as a function of voltage, dashed lines are plotted at $V_n = \frac{nhf}{2e}$. **f** Theoretical maps calculated at f=4.236 GHz with the RSJ model,see supp. info, using two different CPRs: A conventional 2π periodic CPR $I_J = I_c \sin(\varphi)$ is used for upper panel, it reproduces properly the experimental data. An unconventional CPR $I_J = I_c(\frac{4}{5}\sin(\varphi) + \frac{1}{5}\sin(\varphi/2))$ is used for the lower panel where the odd steps have a lower current amplitude.

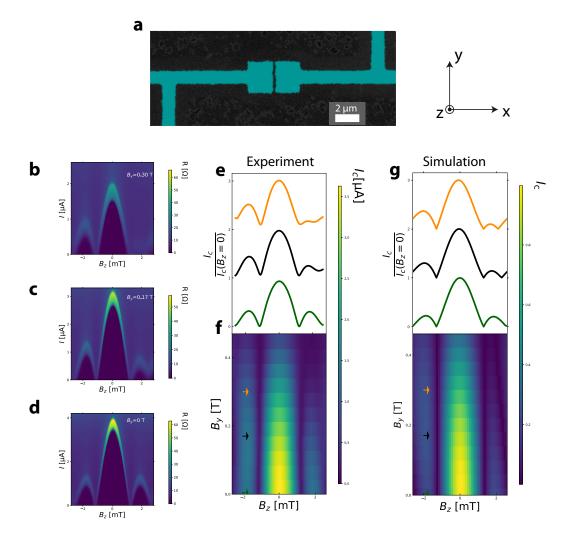


Figure 3: Asymmetric Fraunhofer pattern. a SEM image of a single junction device. The spacing between the two superconducting electrodes is L=150 nm and the width of the junction W=2 μ m. bcd Resistance maps as function of current and perpendicular magnetic field B_z , for different values of the in-plane magnetic field B_y . The corresponding critical current curves are shown panel e. At zero in-plane magnetic field, panel d, the Fraunhofer pattern is symmetric with respect to B_z . The pattern becomes asymmetric upon increasing B_y . f Critical current map as a function of B_z and B_y showing the evolution from symmetric Fraunhofer pattern at $B_y = 0$ to the asymmetric Fraunhofer pattern for $B_y > 0$. g Numerical simulation of the anomalous Fraunhofer pattern due to disorder and spin-orbit coupling. The model is described in the Supp. Note 4.

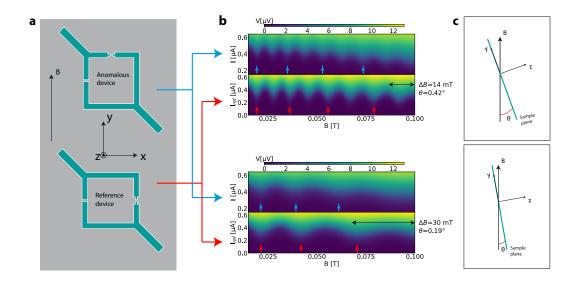


Figure 4: **Probing the** φ_0 **Josephson effect.** a Sketch of the setup consisting of two JIs fabricated on the same chip. From table I, in the absence of disorder, an anomalous phase shift induced by Rashba spin-orbit coupling can be generated only by an in-plane magnetic field B_y . b Voltage map showing the critical current oscillation of the two devices as a function of magnetic field B. The critical current of both devices oscillate due to the perpendicular component of the magnetic field $B_z = B\sin(\theta)$, as sketched panel c. The oscillation frequency can be changed by mechanically tilting the sample, i.e by changing the angle θ between the plane containing the superconducting loop and the magnetic field B. The frequency of the anomalous device is larger than the reference as a consequence of the anomalous phase shift. The colored arrows are guide to the eyes, to help visualizing the increased phase shift in the anomalous device.

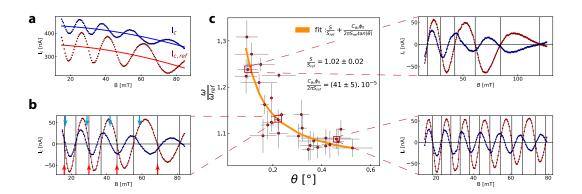


Figure 5: Comparison of the JIs frequencies as a function of the angle θ . a The critical current is extracted and shown as a function of magnetic field. The red and blue curves correspond to the reference and anomalous device respectively. As the critical current of the large junction decreases with the magnetic field, this leads to a decreasing background fitted for both devices and shown by the continuous lines. **b** Critical current as function of magnetic field where the background, indicated by continuous lines in panel a, are subtracted. The anomalous device shows a larger oscillation frequency than the reference device. The colored arrows help visualizing the increased frequency of the anomalous device (blue arrows) with respect to the reference device (red arrows). Each period are compared one by one and the average of the single period ratios provides the value $\frac{\omega}{\omega_{ref}}$. **c** The ratio of the oscillation frequencies is plotted as a function of the angle θ . Without the generation of an anomalous phase this ratio should be constant and equal to the surface ratio $\frac{S}{S_{ref}} \simeq 1$. This ratio diverges as $\frac{1}{\theta}$ for small θ , as shown by Eq. 3. Fitting the curve with Eq. 3 provides the spin-orbit coefficient α .

Spin-Orbit induced phase-shift in Bi₂Se₃ Josephson junctions

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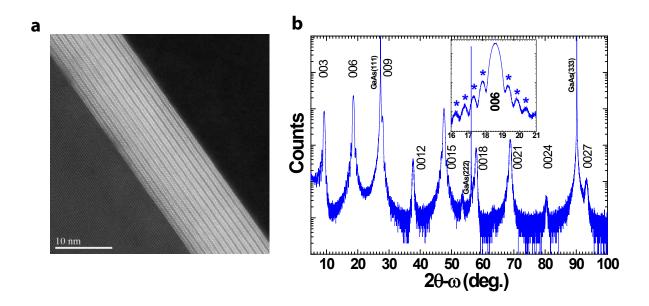
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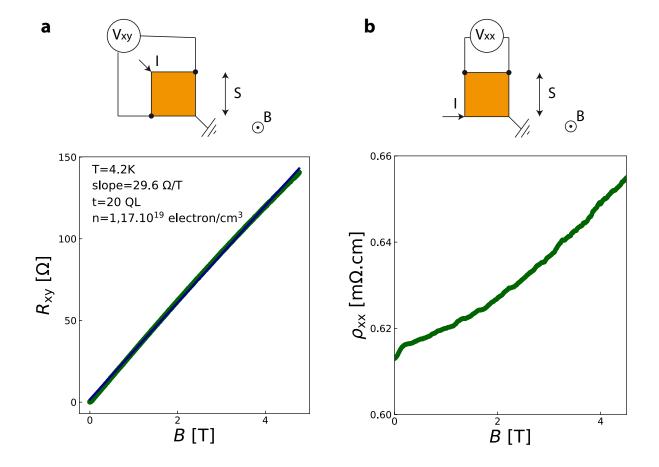
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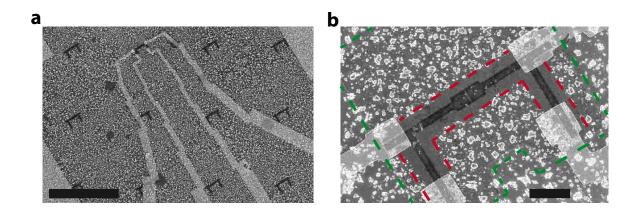
Supplementary Figures



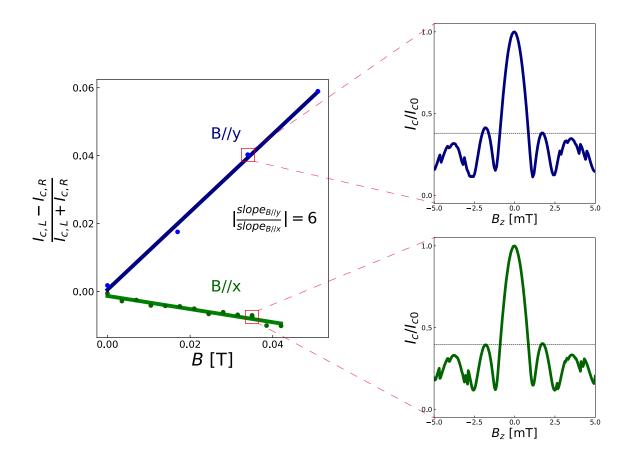
Supplementary Figure 1: Structure of the MBE grown Bi_2Se_3 thin films. a High-angle annular dark-field scanning transmission electron microscopy (HAADF-STEM) cross-section image of Bi_2Se_3 film with 12 quintuple layer (1 QL \approx 1 nm). Each QL is delineated by the fringes with darker contrast located at the weak inter-QL bonds in van-der-Waals gap between each QL. b X-ray diffraction spectrum showing the crystalline structure of the films on the GaAs(111) substrate with highly directed 003-type reflections of the Bi_2Se_3 film along 111-axis of GaAs. The (006) Bragg reflection is enlarged (in insert) with Kiessig fringes (indicated by stars) which are used to determine the film thickness, about 18 QLs for this film.



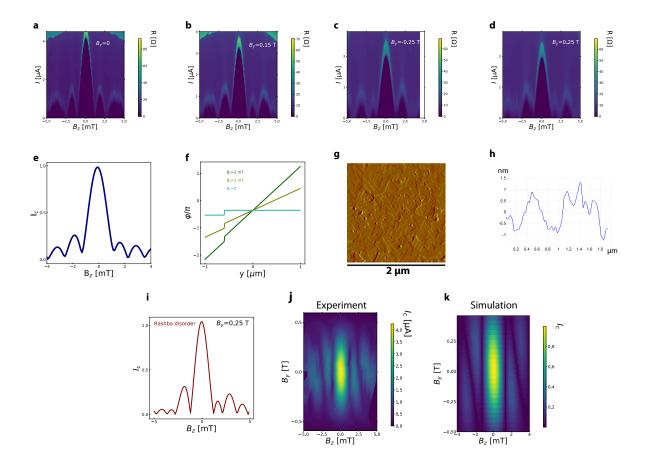
Supplementary Figure 2: Transport properties of the Bi₂Se₃ thin films. Top: Sketch of electrical connections used for measurements of transport properties in the Van der Pauw geometry. The measurements are realized on microfabricated squares of lateral size 380 μ m. Bottom: The plots show the transverse Hall resistance $R_{\rm H}=29.6~\Omega.{\rm T}^{-1}$ (left panel) and longitudinal resistivity $\rho_{xx}=0.61~{\rm m}\Omega.{\rm cm}$ (right panel) measured at T=4.2 K. From the Hall resistance, an electronic density $n=\frac{1}{teR_{\rm H}}=1.2~10^{19}~{\rm electrons.cm}^{-3}$ is determined. Using the effective mass $m^*=0.25~m_e$, Ref. [¹], and the Fermi gas relation between the carrier density and the Fermi velocity, $n=\frac{(m^*v_{\rm F})^3}{3\pi^2h^3}$, one finds $v_{\rm F}$ =3.2 $10^5~{\rm m/s}$. From the Boltzmann relation between the resistivity and the elastic scattering time τ , $\rho_{xx}=m^*/ne^2\tau$, one finds $\tau=0.13$ ps and the elastic mean free path $\ell=v_{\rm F}\tau=42~{\rm nm}$. Because this distance is smaller than the length of the junction $L=150~{\rm nm}$, the system is better described in the diffusive regime, where the diffusion constant is obtained from $D=\frac{v_{\rm F}\tau}{3}=40~{\rm cm}^2{\rm s}^{-1}$.



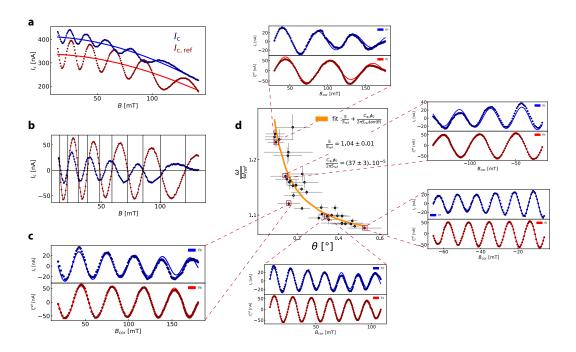
Supplementary Figure 3: SEM images of devices. a Scale bar 100 μ m. On these MBE grown films, many junctions are fabricated and examined by SEM lithography. The best junctions are selected and connected by Ti5 nm/Au75 nm electrodes. b Scale bar 10 μ m. The white grains at the surface are Se grains. Before deposition of the Al electrodes (dark area), the Se capping layer is removed by chemical etching in an NMF solution of Na₂S. Because of the undercut in the PMMA resist, the area on which Se is removed extends beyond the area where the Al electrodes are evaporated. This area where Se is removed is clearly visible and indicated by dashed red lines. After evaporation of the superconducting Al electrodes, the Bi₂Se₃ film is etched to isolate the junction, the etched contour is visible and highlighted by the dashed green line.



Supplementary Figure 4: Fraunhofer pattern as a function of in plane magnetic field orientation. To quantify the asymmetry, we show the parameter $\frac{I_{c,L}-I_{c,R}}{I_{c,L}+I_{c,R}}$ as a function of the amplitude of magnetic field, where $I_{c,L}$ and $I_{c,R}$ correspond to the critical current of the first lobe at negative and positive B_z , respectively. The blue and green curves correspond to in-plane magnetic fields oriented respectively perpendicular and parallel to the current direction. For both orientations, the asymmetry parameter is zero in the absence of in-plane magnetic field. For a finite amplitude of the magnetic field, the asymmetry is much more pronounced when the magnetic field is oriented in the y direction than in the x direction.



Supplementary Figure 5: Simulation of the anomalous Fraunhofer pattern. abcd Differential resistance maps dV/dI as a function of current and magnetic field B_z for different values of the in plane magnetic field B_y . **e** An asymmetric Fraunhofer pattern can be generated simply by a jump in the phase difference between the two superconductors along the direction y as plotted panel **f**. This phase jump can be generated by the in-plane magnetic field in presence of spin-orbit coupling. **g** 2 μ m × 2 μ m AFM topographic image of the thin film. **h** Typical line profile of the sample topography extracted from AFM image. The film thickness changes by ± 1 nm (1 QL) over an average distance of $l_d \approx 1 \mu$ m. **i** Simulation of the Fraunhofer pattern at B_y =0.25 T with a Rashba parameter which changes by 0.1 eVÅ over a length $l_d \approx 1 \mu$ m. **j** Experimental current map showing the evolution of the asymmetry with the magnetic field. **k** Simulation of the anomalous pattern using Eq. 6, where phase jumps are indu@ed along the y direction as a consequence of the change in the Rashba coefficient α with the film thickness.



Supplementary Figure 6: Comparison of the JIs frequencies as a function of the angle θ : second method. a The critical current is shown as a function of magnetic field. The red and blue curves correspond to the reference and anomalous device respectively. The anomalous device shows a larger oscillation frequency than the reference device. As the critical current of the large junction decreases with the magnetic field, this leads to a decreasing background fitted for both devices and shown by the continuous lines. b Critical current as function of magnetic field. The background is subtracted to compare precisely the oscillation frequencies of the two devices. The zeros of critical current are not regularly spaced due to flux focusing. c Critical current of the anomalous (upper panel) and reference (lower panel) JI as a function of the corrected magnetic field B_{cor} . The zeros of critical current are now regularly spaced. The frequencies for the reference and the anomalous devices are extracted from sinusoidal fit shown as continuous lines. d Ratio of the oscillation frequencies $\frac{\omega}{\omega_{ref}}$ as a function of the angle θ . This ratio diverges as $\frac{1}{\theta}$ for small θ due to the anomalous phase generated by spin-orbit coupling.

Supplementary Tables

	Broken by
$\sigma_x P_y$	B_y, α, V_y
$\sigma_y P_y$	B_x, V_y
$P_x P_y T$	$B_x, B_y, \alpha, V_x, V_y$
$\sigma_z P_x P_y T$	V_x, V_y

Supplementary Table 1: Symmetry operations U protecting $H(B_z)=H(-B_z)$, from Ref. [2].

The symmetry operations in the left column are broken by one of the parameters in the right column. These parameters include the in-plane magnetic fields B_x , B_y , the asymmetric disorder potentials V_x , V_y and the spin-orbit coefficient α . To observe a non symmetric Fraunhofer pattern, all symmetries in the first column need to be broken. One ingredient in the line of the second column is enough to break the corresponding symmetry. For example a non symmetric disorder along y, V_y , is enough to break all symmetries in the first column and induce a non symmetric Fraunhofer pattern, $I_c(B_z) \neq I_c(-B_z)$.

Supplementary Notes

Supplementary Note 1. Details on thin films growth. The samples were grown using a multichamber molecular beam epitaxy (MBE) setup at Institut des NanoSciences de Paris. High quality GaAs buffer layers were grown homoepitaxially on GaAs(111) in a Riber compact 21 MBE chamber. The substrates were then transferred under ultrahigh vacuum to a Riber 32 MBE chamber equipped with Bi and Se cells. Growth of Bi₂Se₃ epilayers was then carried out at T=300°C with a Se/Bi beam equivalent pressure ratio higher than 6.5. The growth temperature and Bi/Se flux ratio were fixed at optimal values within the growth parameters interval leading to high quality epilayers. Such values were determined by monitoring the crystalline quality in-situ by reflection high energy electron diffraction and ex-situ by x-ray diffraction, Fig. S1, and by post growth verification of the electronic structure (Dirac cone fingerprint in angle-resolved photoemission spectra³). The thickness of the films was checked by x-ray measurements, Fig. S1. Following growth, the samples were capped with a Se protective layer.

Supplementary Note 2. A.C. Josephson effect. When irradiating a Josephson junction with a microwave signal, its phase oscillates with the frequency f of the applied signal. Standard junctions with a conventional 2π periodic CPR, $I_{\rm J}=I_{\rm c}\sin(\varphi)$, will display superfluid current steps, i.e. the Shapiro steps, at the voltage values $V_n=nhf/2e$.

The CPR of topological Majorana states has been predicted to be 4π periodic^{4–6}, which leads to fractional Shapiro steps. Fractional Shapiro steps have been observed in InSb nanowires driven in the topological regime by a magnetic field ⁷ and in the genuine 3D topological insulator HgTe ⁸.

Bi₂Se₃ has been predicted to be a 3D topological insulator due to its strong spin-orbit interaction that leads to an inverted band structure ⁹. The Dirac cone, which is a predicted characteristic of 3D topological insulators⁹, has been observed by photoemission in the thin film used in this study ³.

To investigate the phase periodicity of the supercurrent we illuminate the junction with microwave. This leads to the resistance maps, shown in Fig. 2abcde, as a function of current and microwave power. Regular steps are observed in the IV curve, Fig. 2d, at voltage $V_n = nhf/2e$ where n is an integer and f is the microwave frequency. The behaviour is well captured by the resistively shunted junction (RSJ) model, Fig. 2f upper panel, with a conventional, 2π periodic, CPR. The absence of 4π periodicity is consistent with past experimental works $^{10-13}$. Residual bulk conduction results in a supercurrent mediated predominantly by trivial states which are 2π periodic in phase.

RSJ model

The A.C. behaviour of a SNS Josephson junction can be captured by the RSJ model. The equivalent circuit of a SNS junction consists of a Josephson junction of critical current I_c in parallel with a resistor with a resistance R_N . The microwave signal is added in the model in the form of an ac current $I_{RF} \sin(2\pi ft)$, with f the microwave frequency. The current in such a circuit is:

$$I = \frac{h}{2eR_{\rm N}} \frac{d\varphi}{dt} + I_{\rm c} \sin(\varphi) + I_{\rm RF} \sin(2\pi f t) \tag{1}$$

This equation is solved numerically for each pair of I and I_{RF} . The voltage V is found from the second Josephson relation by a time average $\langle \rangle_t$ of the phase solution derivative:

$$V = \frac{h}{2e} \langle \frac{d\varphi}{dt} \rangle_t \tag{2}$$

A 4π periodic contribution to the supercurrent can be added by using a CPR of the form $I_{\rm J}=I_{\rm c}(\frac{4}{5}\sin(\varphi)+\frac{1}{5}\sin(\varphi/2))$. The result is shown in the lower panel of Fig. 2f.

The RSJ model has been extended to understand the role of thermal effect which can mask the 4π periodic contribution to the supercurrent in Bi₂Se₃ ¹⁴.

Supplementary Note 3. Periodicity of the Fraunhofer pattern and London penetration depth.

The first node of the Fraunhofer patterns measured on the junction described in the main text, Fig. 3, and the junctions described in Fig. S4 and Fig. S5abcd, are located at the value $B_0 \simeq 1.2$ mT. These two junctions have identical widths W=2 μ m and electrode spacing L=150 nm. The field position of the first node is expected at $B_0 = \frac{\phi_0}{W(L+2\lambda_z)}$.

For the aluminum electrodes, the effective penetration depth $\lambda_{\rm eff}$ is given by:

$$\lambda_{\text{eff}} = \lambda_{\text{L}} \sqrt{1 + \frac{\xi}{\ell}} \tag{3}$$

where $\lambda_L=16$ nm is the bulk London penetration depth of aluminum, ℓ is the mean free path and ξ is the coherence length¹⁵ calculated from:

$$\xi = 0.36\sqrt{\frac{3\hbar v_{\rm F}\ell}{2k_{\rm B}T_{\rm c}}}\tag{4}$$

From the measured critical temperature $T_{\rm c}=0.4~{\rm K}$ of the aluminum titanium bi-layer and mean free path of aluminum $\ell=\frac{\sigma m v_{\rm F}}{ne^2}=50$ nm, we find $\xi=610$ nm and $\lambda_{\rm eff}=58$ nm.

For a magnetic field B_z perpendicular to a thin film, the penetration depth is given by 16 :

$$\lambda_z = \lambda_{\text{eff}} \coth(\frac{d}{\lambda_{\text{eff}}}) \tag{5}$$

For a film of thickness d=20 nm, we find $\lambda_z=175$ nm. With this value of London penetration depth, we find $B_0\simeq 2$ mT, which is about 2 times larger than the experimental value.

This discrepancy can be explained by flux-focusing effects. Indeed, flux-focusing increases the magnetic field in the junction. A simple way to take this effect into account is given in ¹⁷: when the electrode becomes superconducting, the magnetic flux lines which are close to the junction are diverted into the junction area. The effect is present at both electrodes and is equivalent to an increase in the junction area by $(W - 2\lambda_z)^2/2$. This yields $B_0 \approx 0.9$ mT which is close to the experimental value.

In Fig. S4 and Fig. S5, abrupt jumps of the critical current magnitude are observed for $B_z \gtrsim$ 3 mT. Such jumps are expected in presence of trapped vortices. Similar behavior has been observed in Josephson junctions fabricated with type II superconducting electrodes¹⁸. In our case, despite

the modified London penetration depth and coherence length in our thin films, we have $\xi \approx 10 \lambda_{\rm eff}$, which implies that the aluminum remains of type I and no vortices are expected in the electrodes.

However, in hybrid Josephson junctions, the effective penetration depth in the semiconducting material is expected to be much larger than for the superconducting electrodes because the carrier density in the semiconductor is much smaller than in the electrodes. Thus, it is quite plausible that vortices can form inside the semiconducting material near the interface with the superconducting electrodes. This probably explains the ubiquitous observation of flux-trapping effects in hybrids SNS junctions made from semiconducting materials^{13,18}.

Supplementary Note 4. Simulation of the asymmetric Fraunhofer pattern A general relation for the critical current as a function of perpendicular B_z and in-plane magnetic field B_y is given by :

$$I_{c}(B_{z}, B_{y}) = \max_{\varphi'} \int_{-W/2}^{W/2} \int_{0}^{d} j_{0} \sin(\varphi' + \varphi_{xy}(y) + \varphi_{xz}(z) + \varphi_{0}(y)) dydz$$
 (6)

where j_0 the critical current density, $d \simeq 20$ nm the thickness of the film, φ' an arbitrary global phase shift, $\varphi_{xy}(y) = \frac{2\pi(L+2\lambda_z)yB_z}{\phi_0}$ and $\varphi_{xz}(z) = \frac{2\pi(L+2\lambda_{\rm eff})zB_y}{\phi_0}$, are the magnetic fluxes produced in the junction by the magnetic field B_z and B_y respectively, where L=150 nm is the distance between the superconducting electrodes.

Finally, the last phase argument $\varphi_0(y)$ in Eq. 6 is the anomalous phase which is allowed to

depend on y due to disorder¹⁹:

$$\varphi_0 = \frac{\tau m^{*2} E_{\rm Z}(\alpha L)^3}{3\hbar^6 D} \tag{7}$$

where $\tau=0.13$ ps is the elastic scattering time, $D=40~{\rm cm^2 s^{-1}}$ is the diffusion constant, $m^*=0.25~m_e$ is the effective electron mass, $\alpha(y)$ is the spin-orbit coefficient that depends on disorder, $E_{\rm z}=\frac{1}{2}g\mu_{\rm B}B$ is the Zeeman energy with $g=19.5^{20}$. As shown by photoemission, the Rashba parameter depends on the thickness of the film²¹. Using Eq. 7, one finds that a change of the Rashba coefficient by $\Delta\alpha=0.1~{\rm eV.\AA}$ leads to a phase jump of $\Delta\varphi_0\simeq0.2\pi$. This phase jump along the y-direction is sketched Fig. S5f and is sufficient to generate an asymmetric Fraunhofer pattern, as shown in Fig. S5e.

The mere existence of a large value for α does not lead to an asymmetric Fraunhofer pattern, as the induced anomalous phase-shift φ_0 can always be compensated by the arbitrary phase φ' . In other words, because in Eq.6 the critical current is obtained by maximizing over the arbitrary phase φ' , a global change of φ_0 will be compensated by an equivalent change of the arbitrary phase φ' . Only anomalous phase jumps along the y direction can generate an asymmetric Fraunhofer pattern, in agreement with Table S1 indicating that finite disorder V_y must be present for the asymmetry to be present.

AFM topographic images of our MBE films, Fig. S5gh, show that the film thickness changes by an amount ± 1 nm over a length $l_{\rm d}=1~\mu{\rm m}$. We model the variation in the spin-orbit coefficient by the function $\alpha(y)=\alpha_0+\Delta\alpha\sin(2\pi y/l_{\rm d})$ where $\Delta\alpha=0.1$ eV.Å. The resulting Fraunhofer

pattern is shown in Fig. S5hk, displaying good agreement with the experimental data.

Supplementary Note 5. Comparison of the JIs frequencies as a function of the angle θ (second method). In addition to the method described in the main text for extracting the frequency ratio $\frac{\omega}{\omega_{\text{ref}}}$ between the two interferometers, we present here a second method based on a rescaling of the applied magnetic field. To compare the frequencies of the two interferometers we first remove the critical current background. This is done by fitting the $I_c(B)$ curve of the two devices with a parabola, Fig. S6a, which is removed from the experimental data and shown Fig. S6b.

The oscillation frequency of the reference interferometer should not vary with the amplitude of the magnetic field applied with a small angle θ with the plane of the sample. However, because of flux focusing effects, this frequency is observed to change with the magnetic field, Fig. S6b.

To correct for this flux focusing effect, we rescale the magnetic field, giving the corrected magnetic field scale B_{cor} , such that the reference signal becomes periodic as shown in Fig. S6c. This same corrected scale is applied to the anomalous device. In this corrected field scale, the frequency ratio $\frac{\omega}{\omega_{ref}}$ is extracted and plotted Fig. S6d. At large θ , this ratio is equal to the ratio of areas $S/S_{ref} \simeq 1$, however, for small θ , this ratio increases as $1/\tan(\theta)$, indicating the presence of an anomalous phase shift $\varphi_0 = C_{\varphi_0}B$.

In Fig. S6b and in the main text, the angle θ is determined from the last oscillation period ΔB of the reference device by the relation $\theta = \arcsin(\frac{\phi_0}{S\Delta B})$. The error on the determination of the angle $\delta\theta$ is due to the error $\delta(\Delta B)$ which is estimated as the difference between the last

oscillation period and the before last oscillation period. The error on the angle is given by the relation $\delta\theta = \frac{\phi_0\delta(\Delta B)}{S\Delta B^2\sqrt{1-\left(\frac{\phi_0}{S\Delta B}\right)^2}}.$

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